Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/654,770	PARK ET AL.	
Examiner	Art Unit	
Binh X. Tran	1765	

	SEARCHED		
Class	Subclass	Date	Examiner
438	694	5/4/2005	Br
438	696	5/4/2005	かか
438	697	5/4/2005	44
438	700	5/4/2005	竹
438	710	5/4/2005	防丁
438	718	5/4/2005	めら
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Search keywords and inventors' name using EAST	5/4/2005	5
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